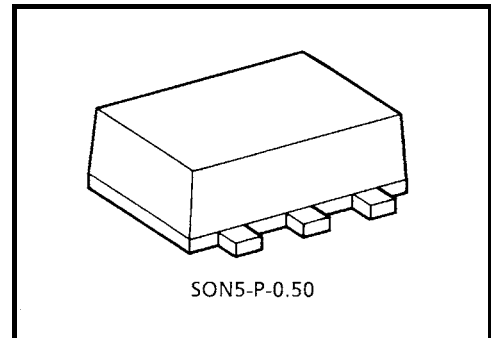


TC7SH34FE

NON-INVERT BUFFER

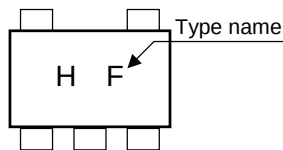
Features

- Super high speed operation : $t_{PD} = 3.8 \text{ ns (typ.)}$
@ $V_{CC} = 5 \text{ V}$
- Low power dissipation : $I_{CC} = 2 \text{ }\mu\text{A (Max.)}$
@ $T_a = 25^\circ\text{C}$
- High noise immunity : $V_{NIH} = V_{NIH}$
 $= 28\% V_{CC} \text{ (Min.)}$
- 5.5V tolerant input.
- Wide operation voltage range : $V_{CC} \text{ (opr)} = 2\sim 5.5 \text{ V}$

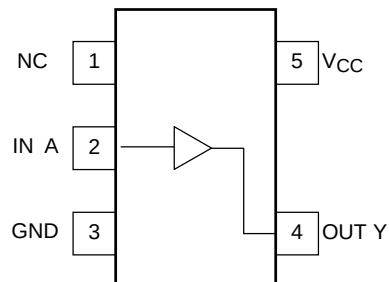


Weight: 0.003 g (typ.)

Marking



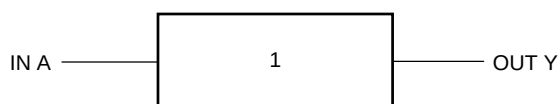
Pin Assignment (top view)



Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	−0.5~7	V
DC input voltage	V _{IN}	−0.5~7	V
DC output voltage	V _{OUT}	−0.5~V _{CC} + 0.5	V
Input diode current	I _{IK}	−20	mA
Output diode current	I _{OK}	±20	mA
DC output current	I _{OUT}	±25	mA
DC V _{CC} /ground current	I _{CC}	±50	mA
Power dissipation	P _D	150	mW
Storage temperature	T _{stg}	−65~150	°C

Logic Diagram



Truth Table

A	Y
L	L
H	H

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit
Supply voltage	V_{CC}	2~5.5	V
Input voltage	V_{IN}	0~5.5	V
Output voltage	V_{OUT}	0~ V_{CC}	V
Operating temperature	T_{opr}	-40~85	°C
Input rise and fall time	dt/dv	0~100 ($V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$)	ns/V
		0~20 ($V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$)	

Electrical Characteristics

DC Characteristics

Characteristics	Symbol	Test Circuit	Test Condition		Ta = 25°C			Ta = −40~85°C		Unit		
					V _{CC} (V)	Min	Typ.	Max	Min		Max	
High-level input voltage	V _{IH}	—	—		2.0	1.5	—	—	1.5	—	V	
					3.0~5.5	V _{CC} × 0.7	—	—	V _{CC} × 0.7	—		
Low-level input voltage	V _{IL}	—	—		2.0	—	—	0.5	—	0.5	V	
					3.0~5.5	—	—	V _{CC} × 0.3	—	V _{CC} × 0.3		
High-level output voltage	V _{OH}	—	V _{IN} = V _{IH}	I _{OH} = −50 μA	2.0	1.9	2.0	—	1.9	—	V	
					3.0	2.9	3.0	—	2.9	—		
					4.5	4.4	4.5	—	4.4	—		
					I _{OH} = −4 mA	3.0	2.58	—	—	2.48		—
					I _{OH} = −8 mA	4.5	3.94	—	—	3.80		—
Low-level output voltage	V _{OL}	—	V _{IN} = V _{IL}	I _{OL} = 50 μA	2.0	—	0	0.1	—	0.1	V	
					3.0	—	0	0.1	—	0.1		
					4.5	—	0	0.1	—	0.1		
					I _{OL} = 4 mA	3.0	—	—	0.36	—		0.44
					I _{OL} = 8 mA	4.5	—	—	0.36	—		0.44
Input leakage current	I _{IN}	—	V _{IN} = 5.5 V or GND		0~5.5	—	—	±0.1	—	±1.0	μA	
Quiescent supply current	I _{CC}	—	V _{IN} = V _{CC} or GND		5.5	—	—	2.0	—	20.0	μA	

AC Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40~85°C		Unit
		V _{CC} (V)	C _L (pF)	Min	Typ.	Max	Min	Max	
Propagation delay time	t_{PLH} t_{PHL}	3.3 ± 0.3	15	—	5.0	7.1	1.0	8.5	ns
			50	—	7.5	10.6	1.0	12.0	
		5.0 ± 0.5	15	—	3.8	5.5	1.0	6.5	
			50	—	5.3	7.5	1.0	8.5	
Input capacitance	C _{IN}			—	4	10	—	10	pF
Power dissipation capacitance	C _{PD}	(Note)		—	13	—	—	—	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

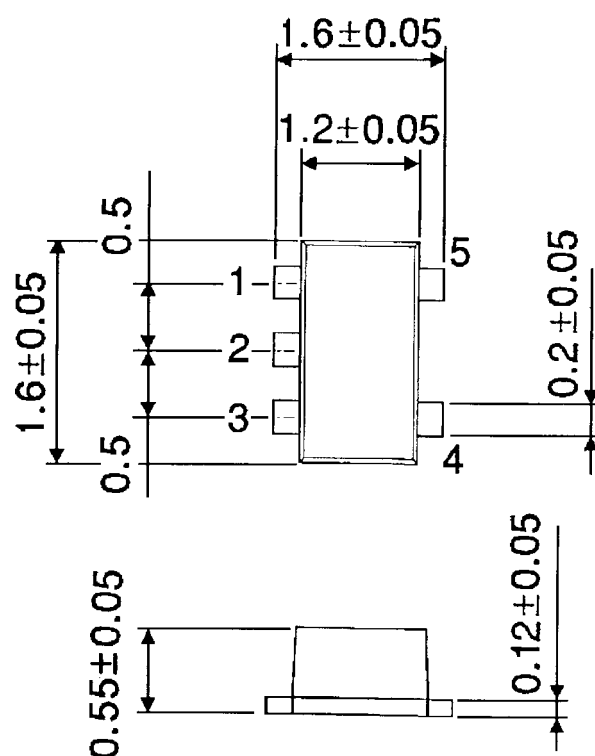
Average operating current can be obtained by the equation.

$$I_{CC(opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

Package Dimensions

SON5-P-0.50

Unit : mm



Weight: 0.003 g (typ.)

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